# 30 V P-Channel POWERTRENCH® MOSFET

# **General Description**

This P-Channel MOSFET is a rugged gate version of ON Semiconductor's advanced POWERTRENCH process. It has been optimized for power management applications requiring a wide range of gave drive voltage ratings (4.5 V - 25 V).

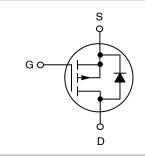
#### **Features**

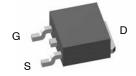
- -40 A, -30 V
  - $R_{DS(ON)} = 20 \text{ m}\Omega @ V_{GS} = -10 \text{ V}$
  - $R_{DS(ON)} = 30 \text{ m}\Omega @ V_{GS} = -4.5 \text{ V}$
- Fast Switching Speed
- High Performance Trench Technology for Extremely Low R<sub>DS(ON)</sub>
- High Power and Current Handling Capability
- Qualified to AEC Q101
- This Device is Pb-Free and are RoHS Compliant



# ON Semiconductor®

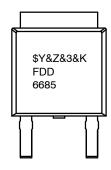
#### www.onsemi.com





DPAK3 (TO-252 3 LD) CASE 369AS

#### **MARKING DIAGRAM**



\$Y = ON Semiconductor Logo &Z = Assembly Plant Code

&3 = Numeric Date Code

kK = Lot Code

FDD6685 = Specific Device Code

# **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

# ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub> = 25°C, Unless otherwise noted)

Symbol	Parameter		Ratings	Units
$V_{DSS}$	Drain-Source Voltage		-30	V
$V_{GSS}$	Gate-Source Voltage		±25	V
I <sub>D</sub>	Continuous Drain Current	@T <sub>C</sub> = 25°C (Note 5)	-40	Α
		@T <sub>A</sub> = 25°C (Note 3a)	-11	
		Pulsed, PW ≤ 100 μs (Note 3b)	-100	
$P_{D}$	Power Dissipation for Single Operation	(Note 3)	52	W
		(Note 3a)	3.8	
		(Note 3b)	1.6	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +175	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{ hetaJC}$	Thermal Resistance, Junction-to-Case (Note 3)	2.9	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction-to-Ambient (Note 3a)	40	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction-to-Ambient (Note 3b)	96	°C/W

<sup>1.</sup> This product has been designed to meet the extreme test conditions and environment demanded by the automotive industry. For a copy of the requirements, see AEC Q101 at http://www.aecouncil.com/

# PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Device	Reel Size	Tape Width	Quantity
FDD6685	FDD6685	13"	16 mm	2500 Units

#### ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
DRAIN-SOUR	CE AVALANCHE RATINGS (NOTE 4)	•				
E <sub>AS</sub>	Single Pulse Drain-Source Avalanche Energy	I <sub>D</sub> = -11 A		42		mJ
I <sub>AS</sub>	Maximum Drain-Source Avalanche Current			-11		Α
OFF CHARACT	TERISTICS	•				
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-30			V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = -250 μA, Referenced to 25°C		-24		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -24 V, V <sub>GS</sub> = 0 V			-1	μΑ
I <sub>GSS</sub>	Gate-Body Leakage	$V_{GS} = \pm 25V, V_{DS} = 0 V$			±100	nA
ON CHARACT	ERISTICS					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-1	-1.8	-3	V
$\Delta V_{GS(th)} / \Delta T_{J}$	Gate Threshold Voltage Temperature Coefficient	$I_D$ = -250 $\mu$ A, Referenced to 25°C		5		mV/°C
R <sub>DS(on)</sub>	Static Drain-Source	$V_{GS} = -10 \text{ V}, I_D = -11 \text{ A}$		14	20	mΩ
	On-Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -9 \text{ A}$		21 20	30	
		$V_{GS} = -10 \text{ V}, I_D = -11 \text{ A}, T_J = 125^{\circ}\text{C}$				

<sup>2.</sup> All ON Semiconductor products are manufactured, assembled and tested under ISO9000 and QS9000 quality systems certification.

# FI FCTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
ON CHARACT	TERISTICS					
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = -10 \text{ V}, V_{DS} = -5 \text{ V}$	-20			Α
9FS	Forward Transconductance	V <sub>DS</sub> = -5 V, I <sub>D</sub> = -11 A		26		S
DYNAMIC CH	ARACTERISTICS					
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = -15 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz		1715		pF
C <sub>oss</sub>	Output Capacitance	VDS = 13 V, VGS = 0 V, 1 = 1.0 W112		440		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			225		pF
$R_{G}$	Gate Resistance	V <sub>GS</sub> = 15 mV, f = 1.0 MHz		3.6		Ω
SWITCHING C	CHARACTERISTICS	•				
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = -15 \text{ V}, I_D = -1 \text{ A}, V_{GS} = -10 \text{ V},$ $R_{GEN} = 6 \Omega$		17	31	ns
t <sub>r</sub>	Turn-On Rise Time			11	21	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			43	68	ns
t <sub>f</sub>	Turn-Off Fall Time			21	34	ns
Qg	Total Gate Charge	$V_{DS} = -15V$ , $I_{D} = -11$ A, $V_{GS} = -5$ V		17	24	nC
Q <sub>gs</sub>	Gate-Source Charge			9		nC
Q <sub>gd</sub>	Gate-Drain Charge			4		nC
DRAIN-SOUR	CE DIODE CHARACTERISTICS AND M	AXIMUM RATINGS				
$V_{SD}$	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = -3.2 A (Note 4)		-0.8	-1.2	V
Trr	Diode Reverse Recovery Time	IF = -11 A,		26		ns
Qrr	Diode Reverse Recovery Charge	diF/dt = 100 A/μs		13		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### NOTES:

mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



4. Pulse Test: Pulse Width < 300  $\mu$ s, Duty Cycle < 2.0%

5. Maximum current is calculated as:  $\overline{R}_{DS(ON)}$ 

where  $P_D$  is maximum power dissipation at  $T_C$  = 25°C and  $R_{DS(on)}$  is at  $T_{J(max)}$  and  $V_{GS}$  = 10 V. 6. Starting  $T_J$  = 25°C, L = 0.69 mH,  $I_{AS}$  = -11 A

#### **TYPICAL CHARACTERISTICS**

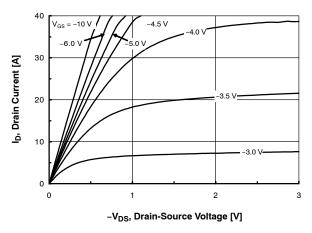


Figure 1. On-Region Characteristics

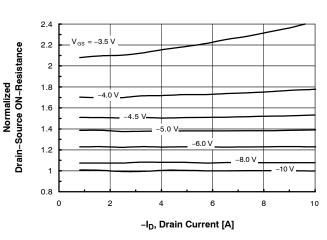


Figure 2. On–Resistance Variation with Drain Current and Gate Voltage

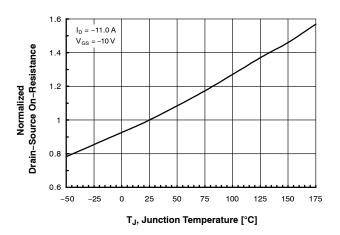


Figure 3. On-Resistance Variation with Temperature

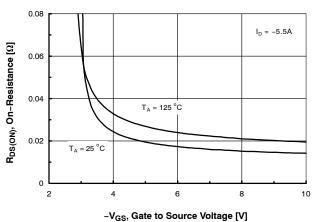


Figure 4. On-Resistance Variation with Gate-to-Source Voltage

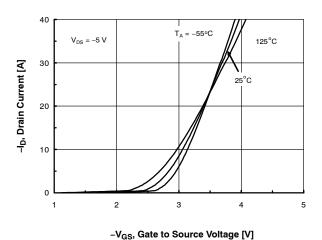
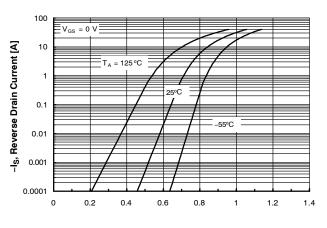


Figure 5. Transfer Charactersistics



-V<sub>SD</sub>, Body Diode Forward Voltage [V]

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

# TYPICAL CHARACTERISTICS (continued)

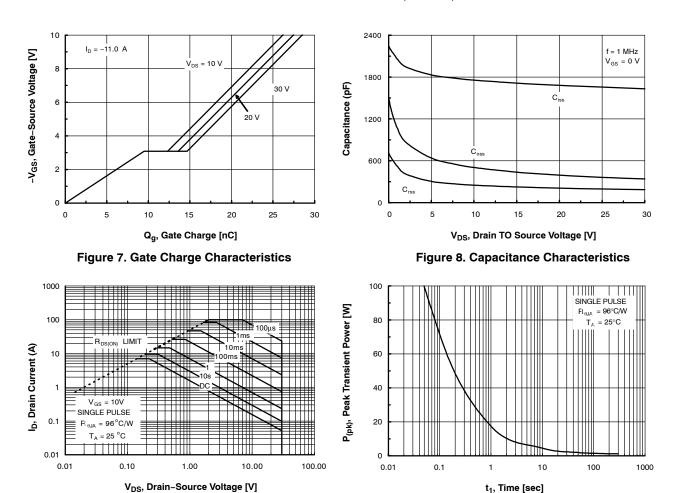


Figure 9. Maximum Safe Operating Area

Figure 10. Single Pulse Minimum Power Dissipation

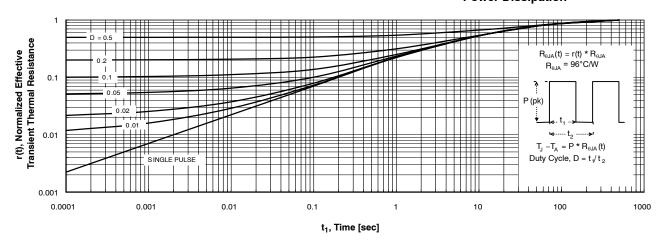


Figure 11. Transient Thermal Response Curve

- NOTES:
- 7. Thermal characterization performed using the conditions described in Note 3b.
- 8. Transient thermal response will change depending on the circuit board design.

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# **DPAK3 (TO-252 3 LD)**CASE 369AS **ISSUE A**

**DATE 28 SEP 2022** 

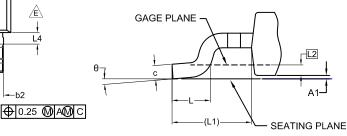
MILLIMETERS

NOTES: UNLESS OTHERWISE SPECIFIED

- A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE C, VARIATION AA.
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
- D) SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED
- CORNERS OR EDGE PROTRUSION.

  FOR DIODE PRODUCTS, L4 IS 0.25 MM MAX.

  F) DIMENSIONS ARE EXCLUSIVE OF BURRS,
- MOLD FLASH AND TIE BAR EXTRUSIONS.
- G) LAND PATTERN RECOMMENDATION IS BASED ON IPC7351A STD TO228P991X239-3N.



**DETAIL A** (ROTATED -90°) SCALE: 12X

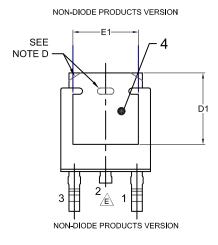
	MIN.	NOM.	MAX.	
Α	2.18	2.29	2.39	
A1	0.00	-	0.127	
b	0.64	0.77	0.89	
b2	0.76	0.95	1.14	
b3	5.21	5.34	5.46	
С	0.45	0.53	0.61	
c2	0.45	0.52	0.58	
D	5.97	6.10	6.22	
D1	5.21	_	_	
Е	6.35	6.54	6.73	
E1	4.32	_	_	
е	2.286 BSC			
e1	4.572 BSC			
Н	9.40	9.91	10.41	
L	1.40	1.59	1.78	
L1	2.90 REF			
12	0.51 BSC			

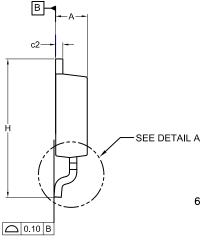
0.89

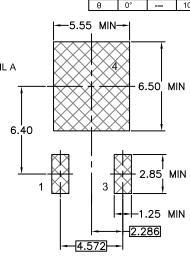
1.08

1.27

1.02







L4

# **GENERIC MARKING DIAGRAM\***

XXXXXX XXXXXX **AYWWZZ** 

XXXX = Specific Device Code

= Assembly Location Α

WW = Work Week

= Assembly Lot Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

# LAND PATTERN RECOMMENDATION

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

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